- There is no single method for designing an x-ray absorption experiment.
- Think carefully about what you are trying to discover about your samples before designing your experiment.
- Aspects of your experimental design depend on the questions you are trying to answer.
- These aspects include:



Expertise



· Choice of beamline and equipment



Samples



· Complementary data



Standards





Choose a question you would like to answer about your sample:

Question	is related to what substances are present in the sample (speciation): Is my sample pure X?
	Is substance X present in my sample? How much of substance X present in my sample? Which of several possible substances are present in my sample?
□ Questio	Which of several possible substances are present in my sample, and in what proportions? ns related to characteristics of the substances in the sample (characterization):
	My sample is a modified version of substance X. How is it different (bond lengths, mesoscale ordering, morphology, site occupancy and vacancies, local disorder, etc.)?
	The average structure and composition of my sample is known. How is the local structure different from the average (bond lengths, site occupancy and vacancies, local disorder, etc.)?
	My sample is strongly disordered or novel and thus its average structure is unknown. What is the immediate coordination environment of each element (ligands, coordination number, bond lengths, disorder, etc.)?
	What is the valence of element Y in my sample?
	My sample contains a small amount of element Y (a dopant or impurity) in an otherwise known substance X. In what environments do the atoms of Y reside?
	I am interested in how the structure of my sample (bond lengths, vacancies, ordering, morphology, site occupancy, etc.) changes with conditions (temperature, pressure, voltage, etc.). I expect only subtle changes, such as a gradual change in bond length or disorder.
	I am interested in how the structure of my sample (bond lengths, vacancies, ordering, morphology, site occupancy, phase composition, etc.) changes with conditions (temperature, pressure, voltage, etc.). I expect qualitative changes, such as the appearance of new phases.

For example: "This is supposed to be a pure crystal of yttrium barium copper oxide, but it's suspected there may be an amorphous contaminant that does not show up in x-ray diffraction. Is it actually pure?"

This is the simplest question to answer by XAFS, and can be done by the <u>fingerprinting</u> technique.



Expertise



Standards



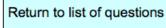
Samples



Beamline and equipment



Complementary data







EXPERTISE

 Answering this question requires very little specialized training.



Expertise



Standards



Samples



Beamline and equipment



Complementary data





SAMPLES

- All you need is the single sample you are interested in measuring.
- It is best if you can make it into a fine powder, but thin films or dilute mixtures (in any phase) also work well.
 For rough determinations a sample in almost any form will work.



Expertise



Standards



Samples



Beamline and equipment



Complementary





STANDARDS

- Obtain a standard of material X.
- If possible, prepare the standard using the same method you use for the sample. For instance, if your sample is powder, try to use a powder for a standard, not a foil.



Expertise



Standards



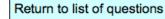
Samples



Beamline and equipment



Complementary data







BEAMLINE AND EQUIPMENT

- Select a beamline with an energy range that includes as many elements in your sample as possible.
- If you can make your sample into a powder with at least 1% molar concentration of x-ray absorbing atoms, use transmission. If not (for example, it's a thin film or a soil sample), consider fluorescence.
- For solutions and hazardous materials, make sure you work with <u>beamline staff</u> well before your experiment to discuss options.



Expertise



Standards



Samples



Beamline and equipment



Complementary data





COMPLEMENTARY DATA

- For crystalline materials, x-ray diffraction will verify long-range order.
- For nanoscale materials, consider utilizing the resources at the <u>Center for</u> <u>Functional Nanomaterials</u>.



Expertise



Standards



Samples



Beamline and equipment



Complementary





For example: "Is there DDT in my samples?"

If there are multiple samples which vary in some way, or one sample measured under a number of conditions, this can best be answered by the principal component analysis (PCA) technique.

For a single sample under a single set of conditions, curve fitting to a theoretical standard, a more difficult but very powerful technique, will be necessary. If that is the case for you, switch to the question "my sample is a modified version of X," as that corresponds more closely to your situation.

In cases where all potential constituents are known, this can be treated as a special case of the question "which of several constituents are present?"







Expertise



Standards



Samples



Beamline and equipment



Complementary data

EXPERTISE

- Perhaps the best technique for answering this question is "principal component analysis" (PCA). This is a fairly simple technique to learn.
- Expect a learning curve of ten to twenty hours to become competent with this technique.



Expertise



Standards



Samples



Beamline and equipment



Complementary data





SAMPLES

- It is highly desirable to have a series of related samples that differ in some way, such as synthesis protocol, environmental source, or aging time (this allows the use of principal component analysis--PCA). Otherwise you have to use the more difficult analysis technique of <u>curve fitting to a theoretical</u> <u>standard</u>.
- It is best if you can make your samples into a fine powder, but thin films or dilute mixtures (in any phase) also work well.



Expertise



Standards



Samples



Beamline and equipment



Complementary data





STANDARDS

- Obtain a standard of material X. It is also useful to have standards for other likely constituents in your sample, but not strictly necessary.
- If the constituents in your sample are nanoscale, but nanoscale standards are not available, bulk standards can be used.
- If possible, prepare the standard using the same method you use for the sample. For instance, if your sample is powder, try to use a powder for a standard, not a foil.



Expertise



Standards



Samples



Beamline and equipment



Complementary data





BEAMLINE AND EQUIPMENT

- Select a beamline with an energy range that includes as many elements in substance X as possible.
- If you can make your samples into powders
 with at least 1% molar concentration of x-ray
 absorbing atoms, use transmission. If not (for
 example, they are thin films or soil samples),
 consider fluorescence.
- For solutions and hazardous materials, make sure you work with <u>beamline staff</u> well before your experiment to discuss options.



Expertise



Standards



Samples



Beamline and equipment



Complementary data





COMPLEMENTARY DATA

- For crystalline materials, x-ray diffraction can be very helpful.
- For nanoscale materials, consider utilizing the resources at the <u>Center for</u> Functional Nanomaterials.
- Measurements of appropriate physical characteristics, such as density, conductivity, or magnetic properties as appropriate, as well as determination of chemical composition ("stoichiometry"), often help.



Expertise



Standards



Samples



Beamline and equipment



Complementary data

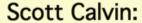




How much constituent X is present?

For example: "How much potassium dichromate is present in my sample?"

Unfortunately, it is difficult to answer this question using XAS without also determining what other compounds with the same absorbing element are present in the sample. You should thus proceed to the question "which of several possible constituents are present, and in what proportions?"



Forward arrow here should go to slide 22, just like hyperlink







Expertise



Standards



Samples



Beamline and equipment



Complementary data

For example: "My soil samples contain a high concentration of chromium compounds, but I'm not sure which."

This is usually best answered by a <u>linear</u> combination analysis, although sometimes principal component analysis (<u>PCA</u>) is helpful as well.



Expertise



Standards



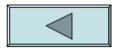
Samples



Beamline and equipment



Complementary data





EXPERTISE

- If you have standards for all phases, this
 can be done by "<u>linear combination</u>
 analysis." This is a relatively straightforward
 technique to learn and apply.
- If you do not have standards for all phases, then use <u>principal component analysis</u> (PCA).
- Expect a learning curve of ten to twenty hours to become competent in either of these techniques.



Expertise



Standards



Samples





Complementary data





SAMPLES

- If you do not have standards for all suspected constituents, then you need a series of related samples that differ in some way (this allows the use of principla component analysis, PCA). If you do have standards for all suspected constituents, then you can analyze a single sample.
- It is best if you can make your samples into a fine powder, but thin films or dilute mixtures (in any phase) also work well.







Expertise



Standards



Samples



Beamline and equipment



Complementary data

STANDARDS

- Obtain standards for as many of the candidate constituents as you are able.
- Bulk standards are OK, even if constituents are nanoscale.
- If possible, prepare the standard using the same method you use for the sample. For instance, if your sample is powder, try to use a powder for a standard, not a foil.
- If an appropriate standard for one of the constituents is not available or does not exist, try to include a standard with the correct valence, and, ideally, the correct nearest-neighbor coordination.
 For example, FeCl₂ is a reasonable analog for Fel₂.







Expertise



Standards



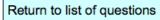
Samples



Beamline and equipment



Complementary data



BEAMLINE AND EQUIPMENT

- Select a beamline with an energy range that includes as many elements in your sample as possible.
- If you can make your samples into powders
 with at least 1% molar concentration of x-ray
 absorbing atoms, use transmission. If not (for
 example, they are thin films or soil samples),
 consider fluorescence.
- For solutions and hazardous materials, make sure you work with <u>beamline staff</u> well before your experiment to discuss options and safety issues.



Expertise



Standards



Samples



Beamline and equipment



Complementary data





COMPLEMENTARY DATA

- For crystalline materials, x-ray diffraction can be very helpful.
- For nanoscale materials, consider utilizing the resources at the <u>Center for</u> Functional Nanomaterials.
- Measurements of appropriate physical characteristics, such as density, conductivity, or magnetic properties as appropriate, as well as determination of chemical composition ("stoichiometry"), often help.



Expertise



Standards



Samples



Beamline and equipment



Complementary data





For example: "My soil samples contain a high concentration of chromium compounds, but I'm not sure which. I'd also like to know how much of each is present."

This is usually best answered by a linear combination analysis.



Expertise



Standards



Samples



Beamline and equipment



Complementary





EXPERTISE

- If you have standards for all phases, and if the phases are not substantially different from the standards (for example, both are highly crystalline), this can be done by "<u>linear combination analysis</u>." This is a relatively straightforward technique to learn and apply.
- For this kind of question, you must learn to carefully normalize your data, and to subtract a background from it in a consistent way.
- Expect a learning curve of ten to twenty hours to become competent in these techniques.
- If some phases do not have good standards (for example, they are nanocrystalline but the standards are bulk), then considerably more training is needed to analyze the data. See the question "my sample is a modified version of substance X" for more advice.







Expertise



Standards



Samples



Beamline and equipment



Complementary data

SAMPLES

- It is best if you can make your samples into a fine powder, but thin films or dilute mixtures (in any phase) also work well.
- Pay special attention to sample preparation for this kind of analysis.



Expertise



Standards



Samples



Beamline and equipment



Complementary





STANDARDS

- Obtain standards for as many of the candidate constituents as you are able.
- Bulk standards are OK, even if constituents are nanoscale.
- If possible, prepare the standard using the same method you use for the sample. For instance, if your sample is powder, try to use a powder for a standard, not a foil. Pay special attention to good sample preparation techniques.
- If an appropriate standard for one of the constituents is not available or does not exist, make sure to include a standard with the correct valence, and, ideally, the correct nearest-neighbor coordination.
 For example, FeCl₂ is a reasonable analog for Fel₂.







Expertise



Standards



Samples



Beamline and equipment



Complementary data

BEAMLINE AND EQUIPMENT

- Select a beamline with an energy range that includes as many elements in your sample as possible.
- If you can make your samples into powders with at least 1% molar concentration of x-ray absorbing atoms, use transmission. If not (for example, they are thin films or soil samples), consider fluorescence.
- For solutions and hazardous materials, make sure you work with <u>beamline staff</u> well before your experiment to discuss options and safety issues.



Expertise



Standards



Samples



Beamline and equipment



Complementary data





COMPLEMENTARY DATA

- For crystalline materials, x-ray diffraction can be helpful.
- For nanoscale materials, consider utilizing the resources at the <u>Center for</u> <u>Functional Nanomaterials</u>.
- Measurements of appropriate physical characteristics, such as density, conductivity, or magnetic properties as appropriate, as well as determination of chemical composition ("stoichiometry"), are recommended.



Expertise



Standards



Samples



Beamline and equipment



Complementary data





My sample is a modified version of substance X. How is it different from X?

It may be different from X in many ways: bond lengths, mesoscale ordering, morphology, site occupancies and vacancies, local disorder, etc.

Examples:

- •"I have nanoscale platinum. How is it different from the bulk?"
- •"I have an amorphous iron oxide. I'd like to know its local structure."
- •"I have a metal adsorbed to a cell wall. How does that resemble known organometallic compounds?"
- •"I have chromium (VI) compounds in a contaminated soil sample. How have they changed from the original contaminants?"
- •"I have a solar cell based on copper indium selenide. But it's the 'defects' that make it work. What are those defects?"
- •"I have a painting that has been exposed to centuries of sunlight. How do the pigments compare to when they were new?"

These questions require <u>curve fitting to a theoretical</u> standard.







Expertise



Standards



Samples



Beamline and equipment



Complementary data

EXPERTISE

- Answering questions of this type requires knowledge of <u>curve fitting to a</u> <u>theoretical standard</u>, a moderately advanced technique.
- It is necessary to take one or more short courses or work with someone knowledgeable in the technique in order to achieve competency.
- Expect a learning curve of forty to eighty hours to achieve basic competency in this technique.







Expertise



Standards



Samples



Beamline and equipment



Complementary data

SAMPLES

 It is best if you can make your sample into a fine powder, but thin films or dilute mixtures (in any phase) also work well.



Expertise



Standards



Samples



Beamline and equipment



Complementary data





STANDARDS

- Obtain a standard of the related material X.
- If possible, prepare the standard using the same method you use for the sample. For instance, if your sample is powder, try to use a powder for a standard, not a foil.



Expertise



Standards



Samples



Beamline and equipment



Complementary data





BEAMLINE AND EQUIPMENT

- Select a beamline with an energy range that includes as many elements in your sample as possible.
- If you can make your samples into powders
 with at least 1% molar concentration of x-ray
 absorbing atoms, use transmission. If not (for
 example, they are thin films or soil samples),
 consider fluorescence.
- For dilute samples, consider a beamline with relatively high flux.
- For solutions and hazardous materials, make sure you work with <u>beamline staff</u> well before your experiment to discuss options and safety issues.







Expertise



Standards



Samples



Beamline and equipment



Complementary data

COMPLEMENTARY DATA

- Studies of this type usually involve sophisticated questions. The more you can add to the "story" by using other characterization techniques, the more convincing the analysis becomes.
- For nanoscale materials, consider utilizing the resources at the <u>Center for</u> Functional Nanomaterials.



Expertise



Standards



Samples



Beamline and equipment



Complementary data





How is the local structure of my sample different from the known average structure?

It is sometimes the case that you know the average structure of your sample, perhaps through x-ray diffraction, but that the local structure is different. This may be due to differences between different regions within a sample (either on a large scale, such as from top to bottom of a soil sample, or on a small scale, such as from surface-side to substrate-side of a thin film), dopants distributed randomly over some set of possible sites, defects such as vacancies or line defects, etc.. These differences may lead to variations in quantities such as bond lengths, site occupancy and vacancies, local disorder.

These questions require <u>curve fitting to a theoretical standard</u>.

This section addresses differences in local structure, not speciation. If you are instead interested in how the mix of constituents varies from region to region within your materials, you need to create separate samples from the different regions or use a microprobe beamline to probe one region at a time, and then proceed according to the question "which of several constituents are present, and in what proportions?"



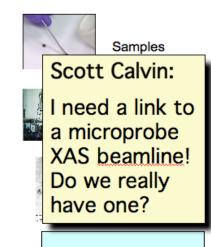




Expertise



Standards



How is the local structure different from the average structure?

EXPERTISE

- Answering questions of this type requires a high level of expertise in <u>curve fitting to a theoretical standard.</u> It is necessary to take short courses and/or work with someone knowledgeable in the technique in order to be successful.
- Expect a learning curve of eighty or more hours to develop the necessary skill with this technique.



Expertise



Standards



Samples



Beamline and equipment



Complementary data





How is the local structure different from the average structure?

SAMPLES

- It is best if you can make your sample into a fine powder, but thin films or dilute mixtures (in any phase) also work well.
- It is sometimes helpful to try to create samples out of different regions of the material and analyze each separately.
- A microprobe beamline can also be used to obtain spectra for individual regions on a sub-millimeter scale.







Expertise



Standards



Samples



Beamline and equipment



Complementary data

How is the local structure different from the average structure?

STANDARDS

- It is often the case that there is a material with a similar structure to the average structure of the sample, but without the local variability.
 For example, a crystal of alpha-mercury (II) sulfide (cinnabar) might make a good standard for mercury sulfides present in soil. If available, other related forms, such as betamercury (II) sulfide, mercury (I) sulfide, elemental mercury, and mercury sulfates would also be helpful.
- If possible, prepare the standards using the same method you use for the sample. For instance, if your sample is powder, try to use a powder for a standard, not a foil.







Expertise



Standards



Samples



Beamline and equipment



Complementary data

How is the local structure different from the average structure?

BEAMLINE AND EQUIPMENT

- Select a beamline with an energy range that includes as many elements in your sample as possible.
- If your sample has distinct regions on a scale of microns to millimeters, consider a microprobe beamline.
- If you can make your samples into powders with at least 1% molar concentration of x-ray absorbing atoms, use transmission. If not (for example, they are thin films or soil samples), consider fluorescence.
- For dilute samples, consider a beamline with relatively high flux.
- For solutions and hazardous materials, make sure you work with <u>beamline staff</u> well before your experiment to discuss options and safety issues.







Expertise



Standards



Samples



Beamline and equipment



Complementary data

How is the local structure different from the average structure?

COMPLEMENTARY DATA

- Studies of this type usually involve sophisticated questions. The more you can add to the "story" by using other characterization techniques, the more convincing the analysis becomes.
- Techniques posessing the spatial resolution to probe the variations directly are extremely helpful. For example, some forms of electron microscopy can yield information such as elemental abundance with nanometer resolution. Consider utilizing the resources of the <u>Center for Functional Nanomaterials</u> if your sample has significant nanoscale variation.



Expertise



Standards



Samples



Beamline and equipment



Complementary data





"Immediate coordination environment" includes questions like what ligands are present, their coordination number, etc..

For example: "I know uranium is present in my soil samples. But I am not sure what it is coordinated to."

This is usually best answered by <u>curve</u> <u>fitting to a theoretical standard</u>.



Expertise



Standards



Samples



Beamline and equipment



Complementary data





EXPERTISE

- Answering questions of this type requires knowledge of <u>curve fitting to a</u> <u>theoretical standard</u>, a moderately advanced technique.
- It is necessary to take one or more short courses or work with someone knowledgeable in the technique in order to achieve competency.
- Expect a learning curve of thirty-five to seventy hours to achieve basic competency in this technique.







Expertise



Standards



Samples



Beamline and equipment



Complementary

SAMPLES

- It is best if you can make your samples into a fine powder, but thin films or dilute mixtures (in any phase) also work well.
- Pay careful attention to sample preparation for this kind of analysis.



Expertise



Standards



Samples



Beamline and equipment



Complementary data





STANDARDS

- Obtain standards for materials with coordination environments similar to those suspected to be present. For example, if a sample is expected to have a mixture of iron-sulfur and iron-oxygen bonds, it's OK to use an iron oxide and an iron sulfide as standards.
- Bulk standards are OK, even if constituents are nanoscale. Crystalline standards are OK, even if the constituents are amorphous.
- If possible, prepare the standard using the same method you use for the sample. For instance, if your sample is powder, try to use a powder for a standard, not a foil.







Expertise



Standards



Samples



Beamline and equipment



Complementary data

My sample is highly novel or disordered.

What is the immediate coordination environment of each element?

BEAMLINE AND EQUIPMENT

- Select a beamline with an energy range that includes as many elements in your sample as possible.
- If you can make your samples into powders
 with at least 1% molar concentration of x-ray
 absorbing atoms, use transmission. If not (for
 example, they are thin films or soil samples),
 consider fluorescence.
- For solutions and hazardous materials, make sure you work with <u>beamline staff</u> well before your experiment to discuss options and safety issues.



Expertise



Standards



Samples



Beamline and equipment



Complementary data





COMPLEMENTARY DATA

 Analyses of this type require careful justification. The more you can add to the "story" by using other characterization techniques, the more convincing the analysis becomes.



Expertise



Standards



Samples



Beamline and equipment



Complementary





For example: "What is the valence of chromium in this sample?"

In some cases, a form of <u>fingerprinting</u> using XANES may be suitable. For more quantitative information when multiple valences are suspected, <u>linear</u> <u>combination analysis</u> may be appropriate.



Expertise



Standards



Samples



Beamline and equipment



Complementary data





EXPERTISE

- While advanced techniques are not generally necessary to identify the valence of an element in a sample, it is very helpful to first practice on similar, known materials.
- Expect to practice five to fifteen hours to achieve competency.



Expertise



Standards



Samples



Beamline and equipment



Complementary data





SAMPLES

- All you need is the single sample you are interested in measuring.
- It is best if you can make it into a fine powder, but thin films or dilute mixtures (in any phase) also work well.



Expertise



Standards



Samples



Beamline and equipment



Complementary





STANDARDS

- Obtain standards for materials with absorbing element, valence, and local symmetry (e.g. coordination number) similar to those that might be present.
- Even if you are only interested in valence, try to match coordination number as well. (If coordination number is not known, include standards with different coordination numbers.) Some elements also have "high spin" and "low spin" states; in those cases, try to gather standards of both varieties.
- Bulk standards are OK, even if constituents are nanoscale. Crystalline standards are OK, even if the constituents are amorphous.
- If possible, prepare the standard using the same method you use for the sample. For instance, if your sample is powder, try to use a powder for a standard, not a foil.







Expertise



Standards



Samples



Beamline and equipment



Complementary data

BEAMLINE AND EQUIPMENT

- Select a beamline with an energy range that includes the element that you are interested in.
- If you can make your samples into powders with at least 1% molar concentration of x-ray absorbing atoms, use transmission. If not (for example, they are thin films or soil samples), consider fluorescence.
- For solutions and hazardous materials, make sure you work with <u>beamline staff</u> well before your experiment to discuss options and safety issues.



Expertise



Standards



Samples



Beamline and equipment



Complementary data





COMPLEMENTARY DATA

 Complementary data from other techniques, including x-ray diffraction and microscopy, can help to paint a complete picture of your sample.



Expertise



Standards



Samples



Beamline and equipment



Complementary data





For example, a zinc oxide thin film is doped with a small amount of manganese. Does the manganese form metal clusters, substitute for zinc in the oxide, form MnO, or reside interstitially in the zinc oxide?

In favorable cases, <u>fingerprinting</u> may work, but often this calls for <u>curve fitting</u> to a theoretical standard.



Expertise



Standards



Samples



Beamline and equipment



Complementary





EXPERTISE

- Answering questions of this type frequently requires knowledge of curve fitting to a theoretical standard, a moderately advanced technique.
- It is necessary to take one or more short courses or work with someone knowledgeable in the technique in order to achieve competency.
- Expect a learning curve of forty to eighty hours to achieve basic competency in this technique.







Expertise



Standards



Samples



Beamline and equipment



Complementary data

SAMPLES

 It is best if you can make your sample into a fine powder, but thin films or dilute mixtures (in any phase) also work well.



Expertise



Standards



Samples



Beamline and equipment



Complementary data





STANDARDS

- Obtain a standard of the related material X.
- Also obtain standards for materials with a similar local environment to possibilities being considered for the environment of Y. For instance, if a small amount of Zn is doped into FeO, some possibilities are that zinc is present in metallic clusters, substituted for iron in the FeO structure, or present in ZnO clusters. Thus Zn, FeO, and ZnO standards should be measured.
- Sometimes, the related material X does not contain any elements with edges that can be measured on the beamline being used. In that case, it is not necessary to have a standard for X. (For example, many hard x-ray beamlines cannot measure the silicon edge. If you are using a beamline of that type and your sample is SiO₂ doped with chromium, it is not necessary to bring a pure SiO₂ standard.)
- · Bulk standards are OK, even if constituents are nanoscale.
- If possible, prepare the standard using the same method you use for the sample. For instance, if your sample is powder, try to use a powder for a standard, not a foil.







Expertise



Standards



Samples



Beamline and equipment



Complementary data

BEAMLINE AND EQUIPMENT

- Select a beamline with an energy range that includes element Y. It is also helpful to be able to measure edges in substance X.
- If you can make your samples into powders with at least 1% molar concentration of x-ray absorbing atoms, use transmission. If not (for example, they are thin films or soil samples), consider fluorescence.
- For dilute samples, consider a beamline with relatively high flux.
- For solutions and hazardous materials, make sure you work with <u>beamline staff</u> well before your experiment to discuss options and safety issues.







Expertise



Standards



Samples



Beamline and equipment



Complementary data

COMPLEMENTARY DATA

- Studies of this type usually involve sophisticated questions. The more you can add to the "story" by using other characterization techniques, the more convincing the analysis becomes.
- X-ray diffraction and chemical composition ("stoichiometry") are often particularly helpful.



Expertise



Standards



Samples



Beamline and equipment



Complementary data





I want to know how the structure of my sample changes with conditions. I expect qualitative changes.

By "qualitative changes," we mean changes such as the appearance of new constituents or changes in local symmetry.

For example, a copper sulfide electrode may be exposed to repeated cycling of the applied voltage. At different points in these cycles, copper metal, Cu₂S, and CuS may be present in differeing proportions.

Other examples of changes in conditions are changes in temperature or pressure.

In favorable cases, <u>linear combination analysis</u> might work. Often, however, the individual constituents are significantly different from available standards, in which case <u>curve fitting to a theoretical standard</u> is called for.



Expertise



Standards



Samples



Beamline and equipment



Complementary data

EXPERTISE

- Answering questions of this type frequently requires knowledge of <u>curve</u> <u>fitting to a theoretical standard</u>, a moderately advanced technique.
- It is necessary to take one or more short courses or work with someone knowledgeable in the technique in order to achieve competency.
- Expect a learning curve of fifty to eighty hours to achieve basic competency in this technique.







Expertise



Standards



Samples



Beamline and equipment



Complementary

SAMPLES

- For an ex situ measurement, identical samples are exposed to different conditions, and then prepared for measurements. The effect of annealing, for instance, will most likely be done in this way. As a rule of thumb, it is generally beneficial to prepare five to ten ex situ samples from a given material (e.g. cathodes removed at five to ten different points in a charging cycle).
- For in situ measurements, a sample may be exposed to different conditions at the beamline; for instance, temperature may be varied. Time resolved experiments are a special case of in situ measurements.
- In some fields, the term <u>operando</u> is used to indicate measurements on a material as it is performing its intended function; for example, a catalyst under its usual reaction conditions or a cathode in an operating battery.
- In situ and operando measurments are usually performed on only a small number of distinct materials in a given run.







Expertise



Standards



Samples



Beamline and equipment



Complementary

STANDARDS

- Obtain standards for relevant pure phases. For instance, an electrode might be expected to cycle from a mixture of Cu and Cu₂S to a mixture of Cu₂S and CuS as a function of voltage and number of cycles. Cu, Cu₂S, and CuS should be used as standards.
- If possible, prepare the standard using the same method you use for the sample. For instance, if your sample is powder, try to use a powder for a standard, not a foil.
- If an appropriate standard for one of the constituents is not available or does not exist, make sure to include a standard with the correct valence, and, ideally, the correct nearest-neighbor coordination.
 For example, FeCl₂ is a reasonable analog for Fel₂.







Expertise



Standards



Samples



Beamline and equipment



Complementary data

(Qualitative changes expected) BEAMLINE AND EQUIPMENT

- Select a beamline with an energy range that includes as many elements in your sample as possible.
- If you can make your samples into powders with at least 1% molar concentration of x-ray absorbing atoms, use transmission. If not (for example, they are thin films or soil samples), consider fluorescence.
- For in situ or operando measurements, be sure to consult with beamline and safety personnel well in advance of the experiment. In some cases, they may have equipment you can use, but in all cases you will be interfacing with their equipment. As a simple example, your equipment needs to fit in their hutch! Safety issues need to be considered--what is safe in your lab may not be in the NSLS environment.



Expertise



Standards



Samples



Beamline and equipment



Complementary





COMPLEMENTARY DATA

- Complementary data is usually crucial for this kind of experiment.
- Some data (e.g. conductivity) might be able to be measured at the beamline in an in situ experiment.
- In other cases, you will want to reproduce as closely as possible the conditions the sample is exposed to in the hutch when making measurements elsewhere, such as at the <u>Center for</u> <u>Functional Nanomaterials</u> or your home institution.



Expertise



Standards



Samples



Beamline and equipment



Complementary data





I want to know how the structure of my sample changes with conditions. I expect only subtle changes.

By "subtle changes," we mean changes such as gradual changes in bond length.

For example, a series of measurements on *tert*-butyl bromide might be made as a function of temperature to study changes in the local bromine environment that occur near the melting point.

Curve fitting to a theoretical standard will be needed for this kind of analysis.



Expertise



Standards



Samples



Beamline and equipment



Complementary





EXPERTISE

- Answering questions of this type requires <u>curve fitting to a theoretical</u> <u>standard</u>, a moderately advanced technique.
- It is necessary to take one or more short courses or work with someone knowledgeable in the technique in order to achieve competency.
- Expect a learning curve of forty to eighty hours to achieve basic competency in this technique.







Expertise



Standards



Samples



Beamline and equipment



Complementary data

How does the structure of my sample change with conditions? (Only subtle changes expected) **SAMPLES**

- For an ex situ measurement, identical samples are exposed to different conditions, and then prepared for measurements. The effect of annealing, for instance, will most likely be done in this way. As a rule of thumb, it is generally beneficial to prepare five to ten ex situ samples from a given material (e.g. cathodes removed at five to ten different points in a charging cycle).
- For in situ measurements, a sample may be exposed to different conditions at the beamline; for instance, temperature may be varied. Time resolved experiments are a special case of in situ measurements.
- In some fields, the term operando is used to indicate measurements on a material as it is performing its intended function; for example, a catalyst under its usual reaction conditions or a cathode in an operating battery.
- In situ and operando measurments are usually performed on only a small number of distinct materials in a given run.







Expertise



Standards



Samples



Beamline and equipment



Complementary data

How does the structure of my sample change with conditions? (Only subtle changes expected) **STANDARDS**

 The baseline spectrum of the sample itself serves as the standard; no other standard is needed.



Expertise



Standards



Samples



Beamline and equipment



Complementary data





(Only subtle changes expected) BEAMLINE AND EQUIPMENT

- Select a beamline with an energy range that includes as many elements in your sample as possible.
- If you can make your samples into powders with at least 1% molar concentration of x-ray absorbing atoms, use transmission. If not (for example, they are thin films or soil samples), consider fluorescence.
- For in situ or operando measurements, be sure to consult with beamline and safety personnel well in advance of the experiment. In some cases, they may have equipment you can use, but in all cases you will be interfacing with their equipment. As a simple example, your equipment needs to fit in their hutch! Safety issues need to be considered--what is safe in your lab may not be in the NSLS environment.



Expertise



Standards



Samples



Beamline and equipment



Complementary data





(Only subtle changes expected) COMPLEMENTARY DATA

- Complementary data is often very important for this kind of experiment.
- Some data (e.g. conductivity) might be able to be measured at the beamline in an in situ experiment.
- In other cases, you will want to reproduce as closely as possible the conditions the sample is exposed to in the hutch when making measurements elsewhere, such as at the <u>Center for</u> <u>Functional Nanomaterials</u> or your home institution.



Expertise



Standards



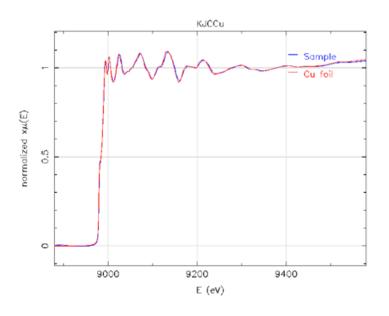
Samples



Beamline and equipment



Complementary



Fingerprinting

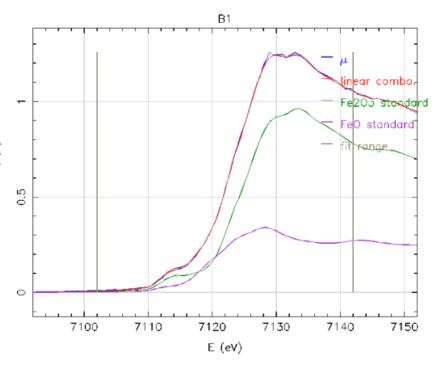
In this technique, the spectrum of a sample is visually compared to the spectrum of a standard to see if they match.

This technique requires very little training, but doesn't work unless the sample is predominantly the same composition as a standard.

Linear Combination Analysis

In this technique, a computer attempts to match the spectrum of a sample by adding together fractions of the spectra of standards.

This technique is easy to learn, but won't work unless there are standards for all constituents.



Principal Component Analysis (PCA)

In this technique, a computer takes linear combinations of a set of spectra in such a way as to create a set of "components" that can account for the spectra, in decreasing order of importance.

This technique is best used when there are multiple related spectra, such as a series of samples or a single sample measured under a variety of conditions.

This technique can provide information about how many different constituents are present, and whether individual constituents are present.

PCA is thus useful when you have limited knowledge about your samples, but plenty of data.

Curve Fitting to a Theoretical Standard

In this technique, a computer calculates a theoretical spectrum based on a guess as to the structure of the material, and then adjusts the guessed structure so as to match the measured spectrum.

This is the only technique which can provide information about structures for which there are no good standards, and is the only way of reliably measuring quantitative information such as bond lengths.

This is also the most difficult technique to learn and apply.

